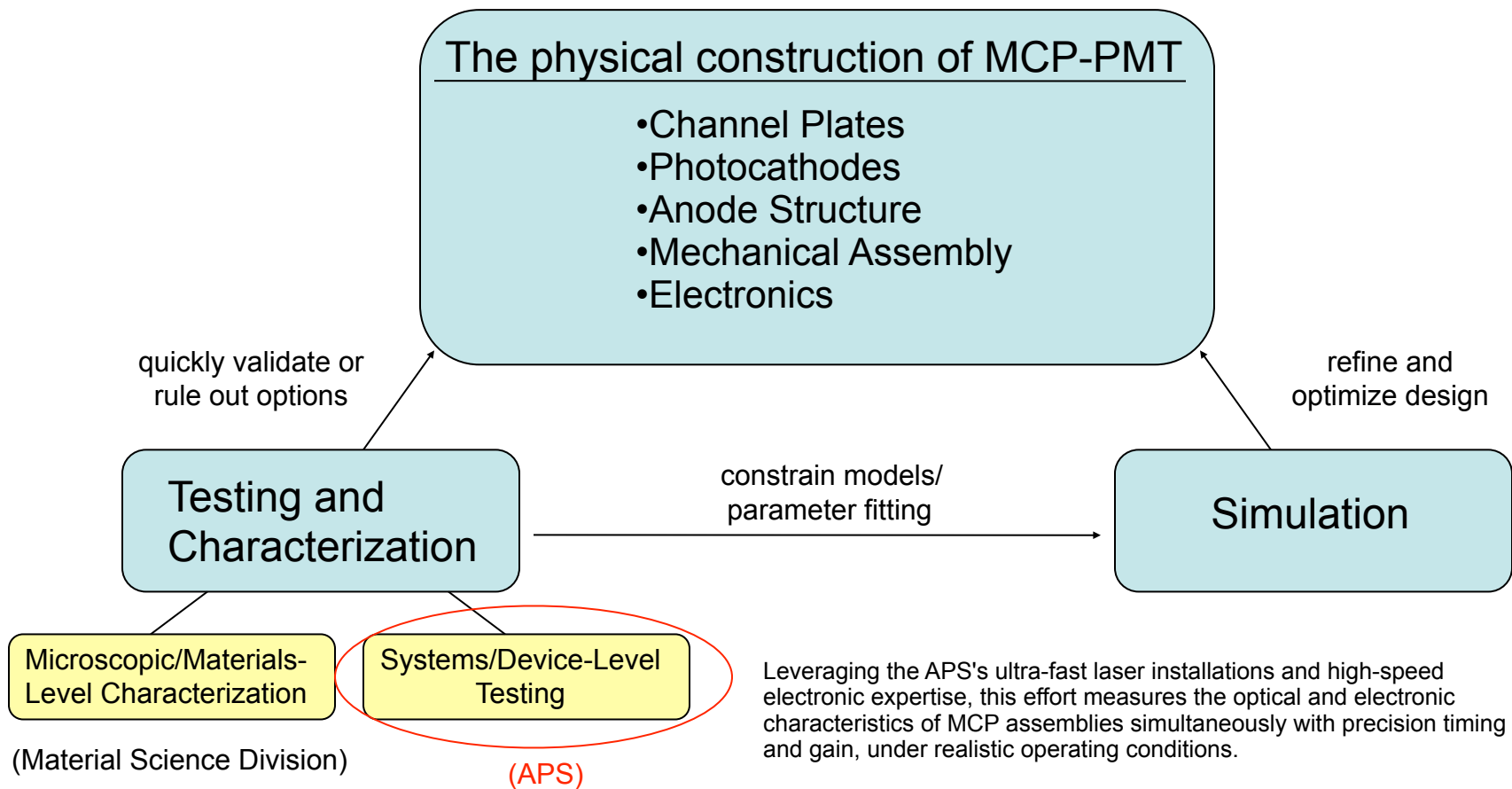
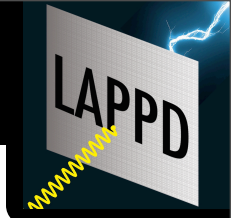


Review of MCP Testing at ANL





Characterization Program

BASE LINE MCP-PMT STACKUP



Characterization Program

Gap Spacing and Voltages

Gap 1: "First Strike":

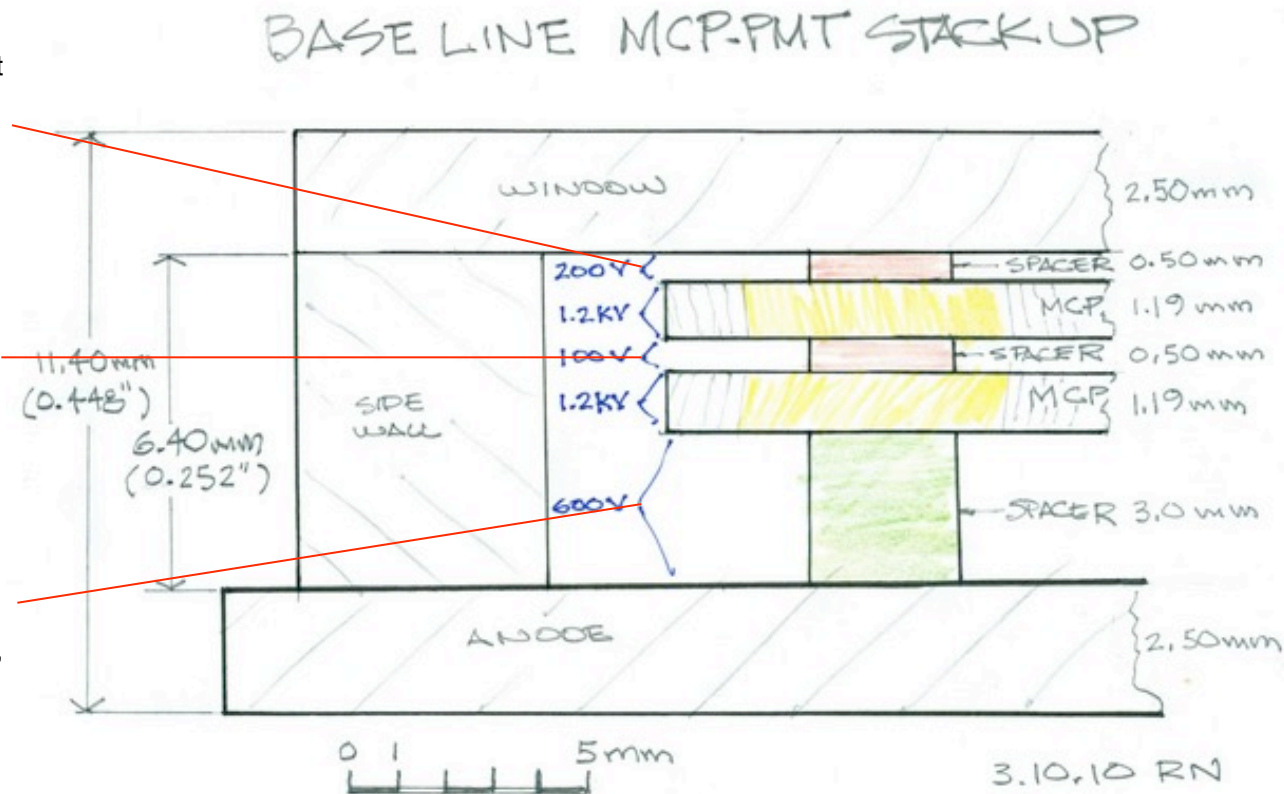
Impacts on variability of transit time and amplification

Gap 2:

Impacts on saturation of MCP pair, spatial spread of signal.

Gap 3:

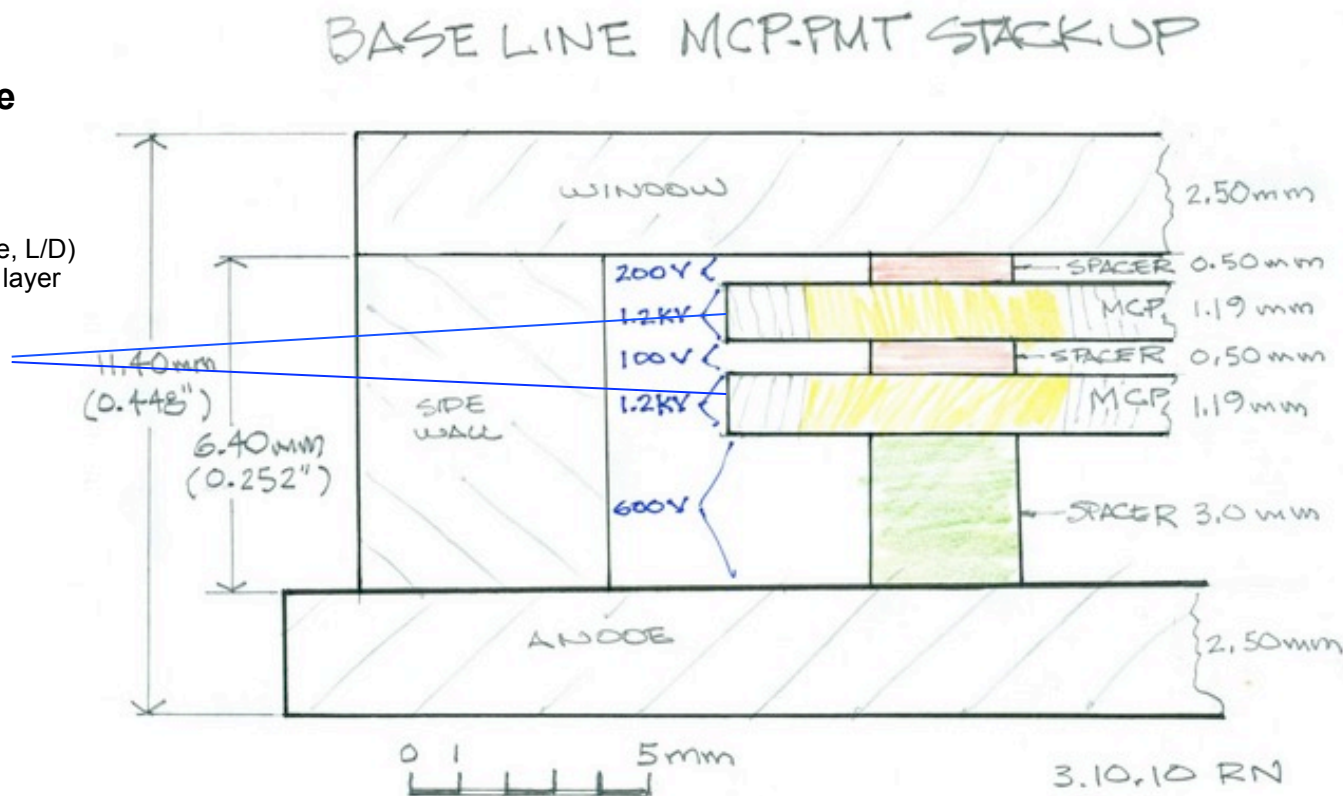
spatial and temporal spreading of the charge cloud, space charge effects, interface with the anode



Characterization Program

MCP Performance

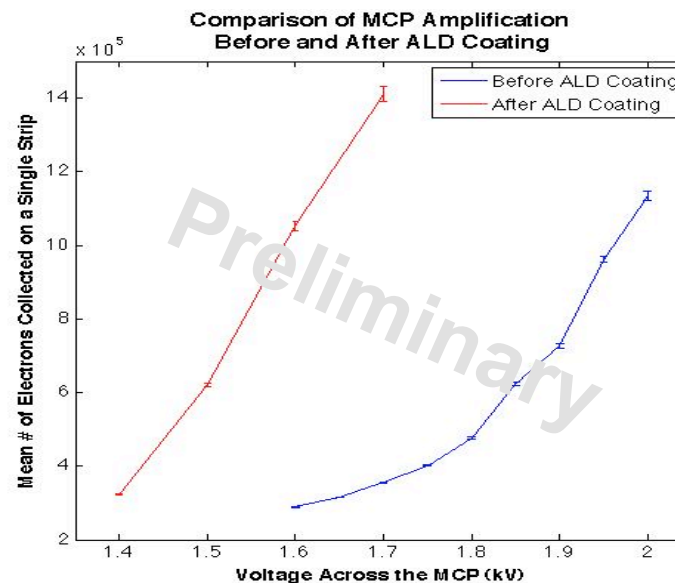
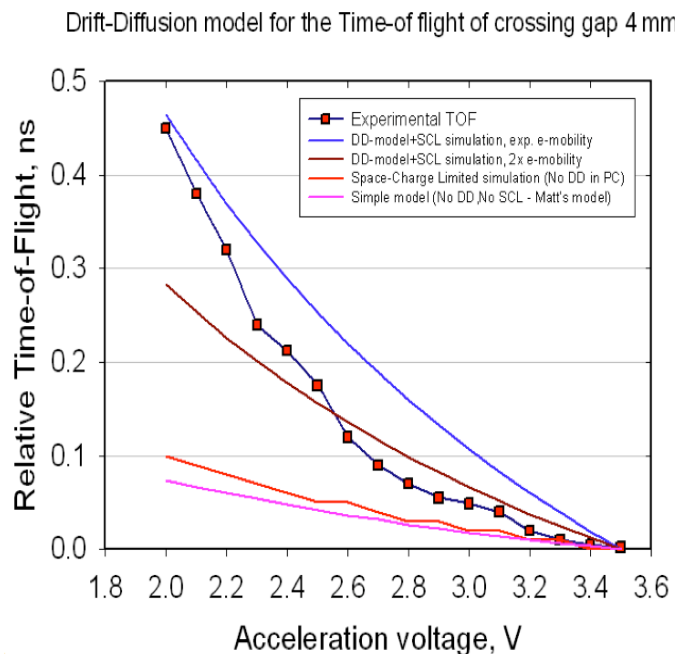
- Operational voltages
- Plate geometry (pore size, L/D)
- Materials: SEE, resistive layer
- Plate quality
 - uniformity
 - noise
 - stability
- Plate resistance
 - saturation
 - relaxation time



A Brief History of the Characterization Program

A-Flange → B'-Flange → B-Flange → Beyond

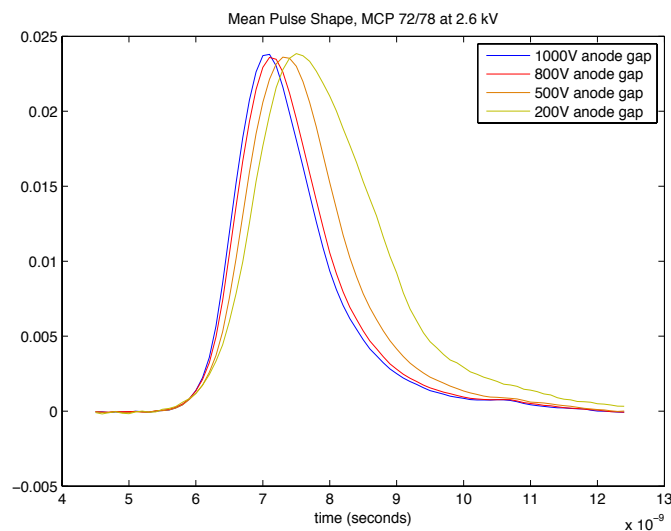
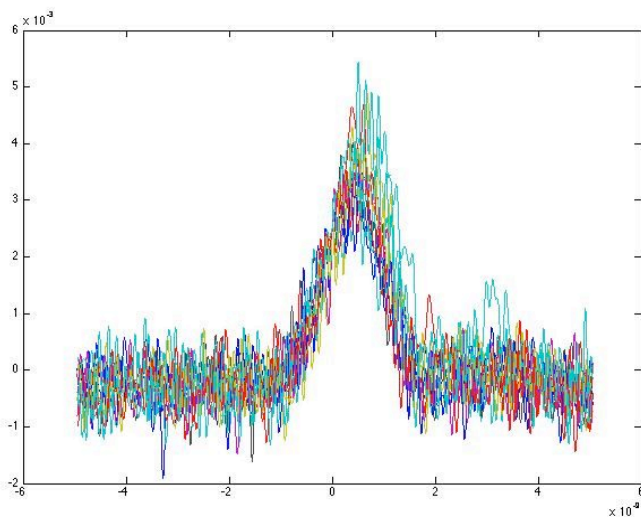
A quick first test setup. Look at some commercial MCPs. Perform preliminary timing measurements. Successful comparison of commercial MCPs, before & after ALD coating of SEE enhanced material.



A Brief History of the Characterization Program

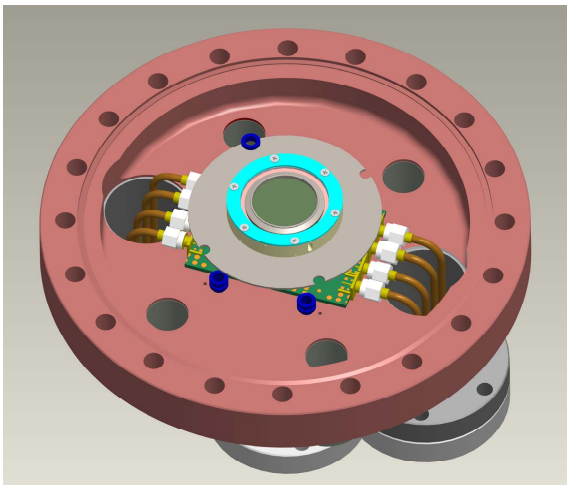
A-Flange → B'-Flange → B-Flange → Beyond

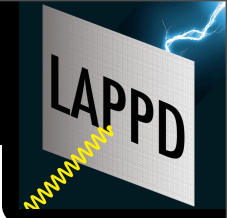
- A transitional setup, built closely to our final specifications.
- Iron out the technical problems in setup/methodology.
- Workout throughput/pipeline issue.
- Perform first measurements of ALD-functionalized MCPs.



A-Flange → B'-Flange → B-Flange → Beyond

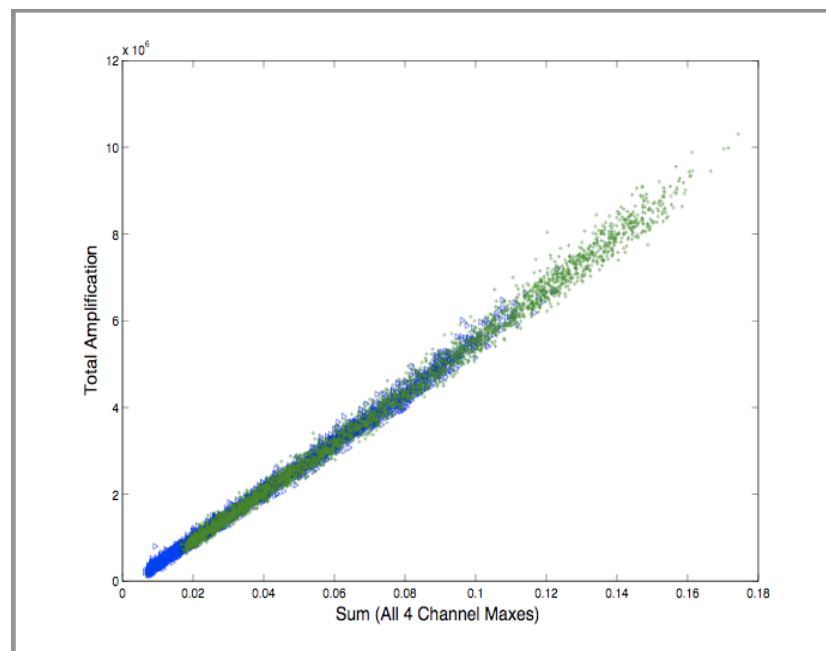
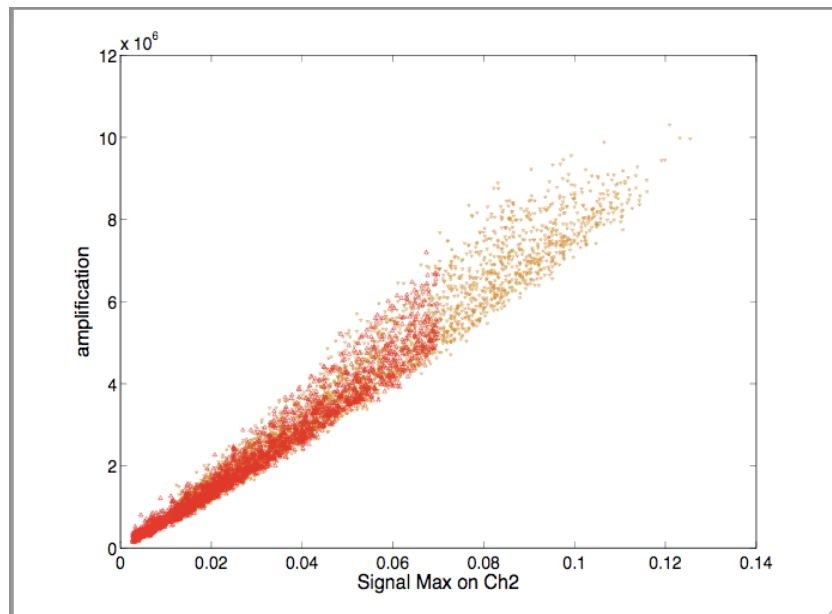
- [illegible]

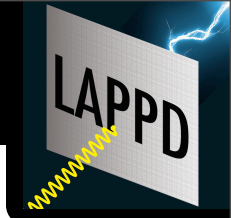




Summarizing the B' Results

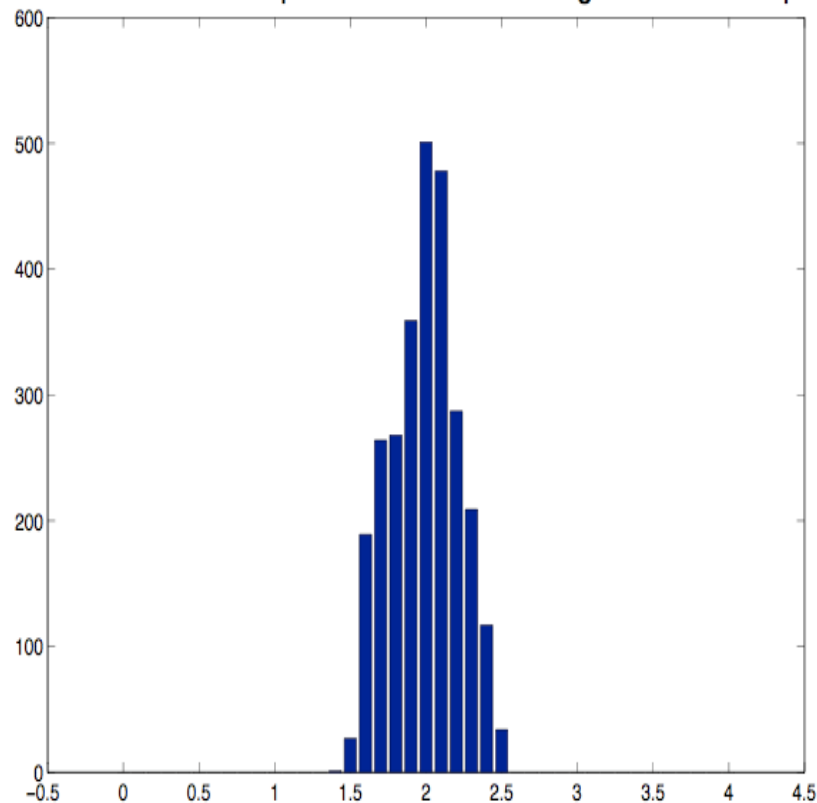
MCP 64/65: Splitting up the Scope Data



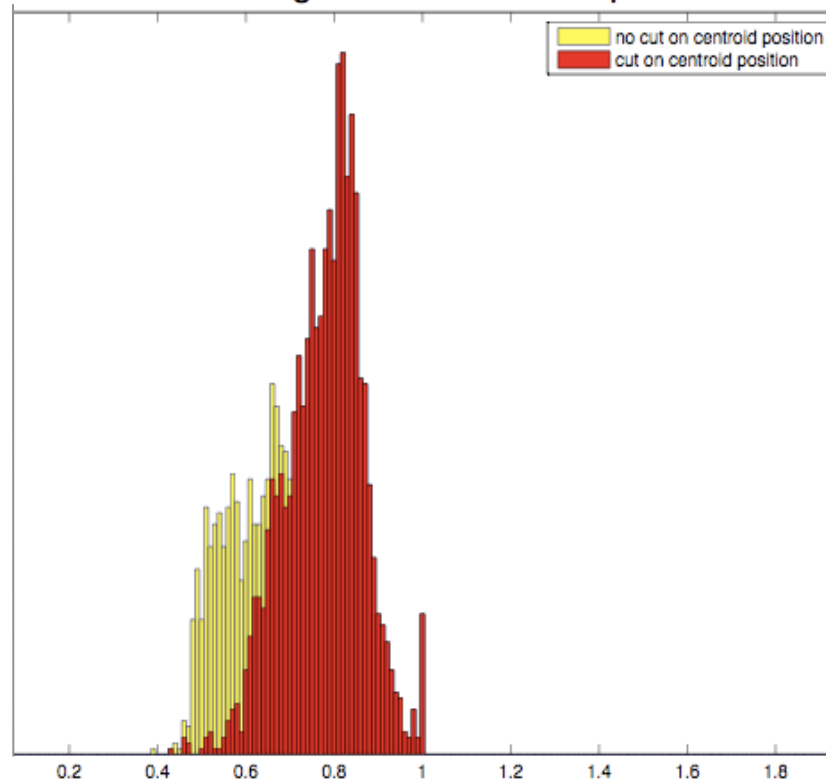


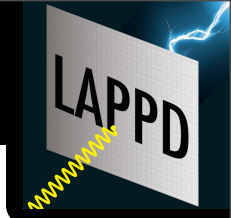
MCP 64/65

Centroid Position in Stripline # For Evts With Signal Max on Stripline 2

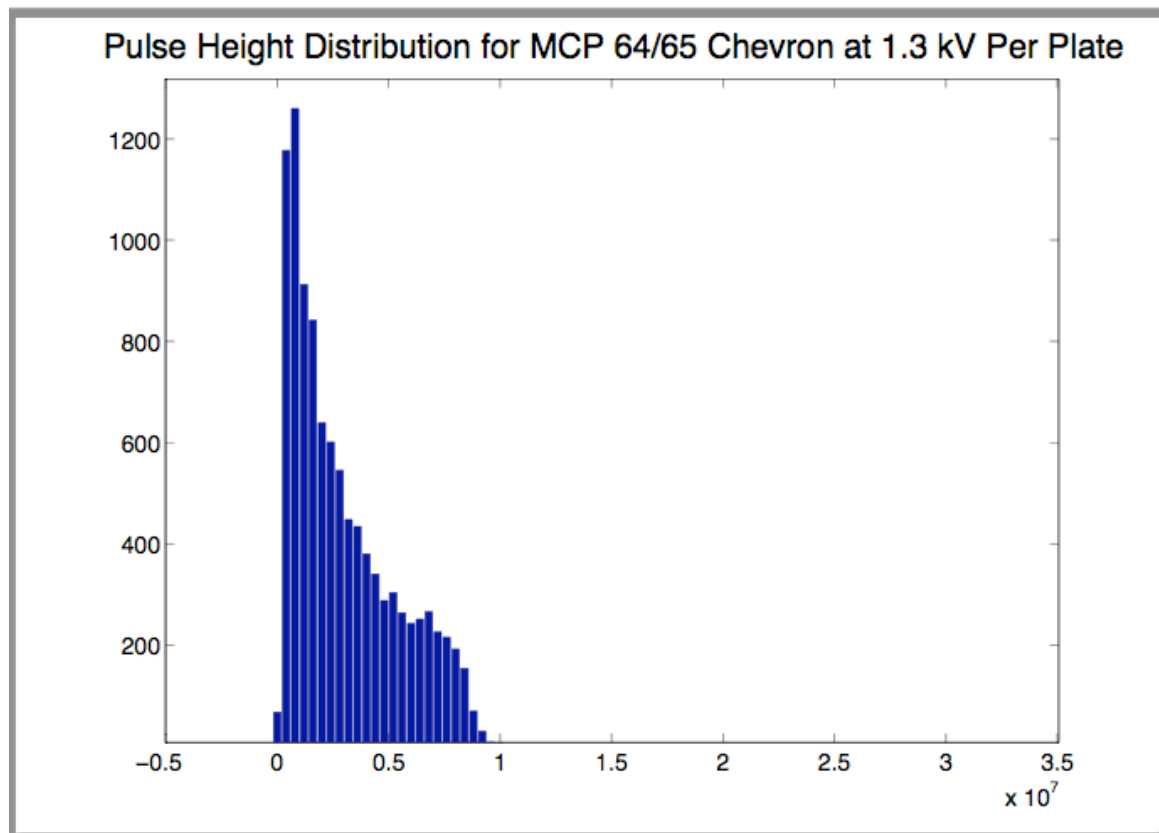


Fractional Charge on Maximum Stripline

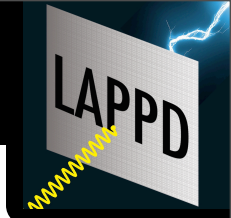




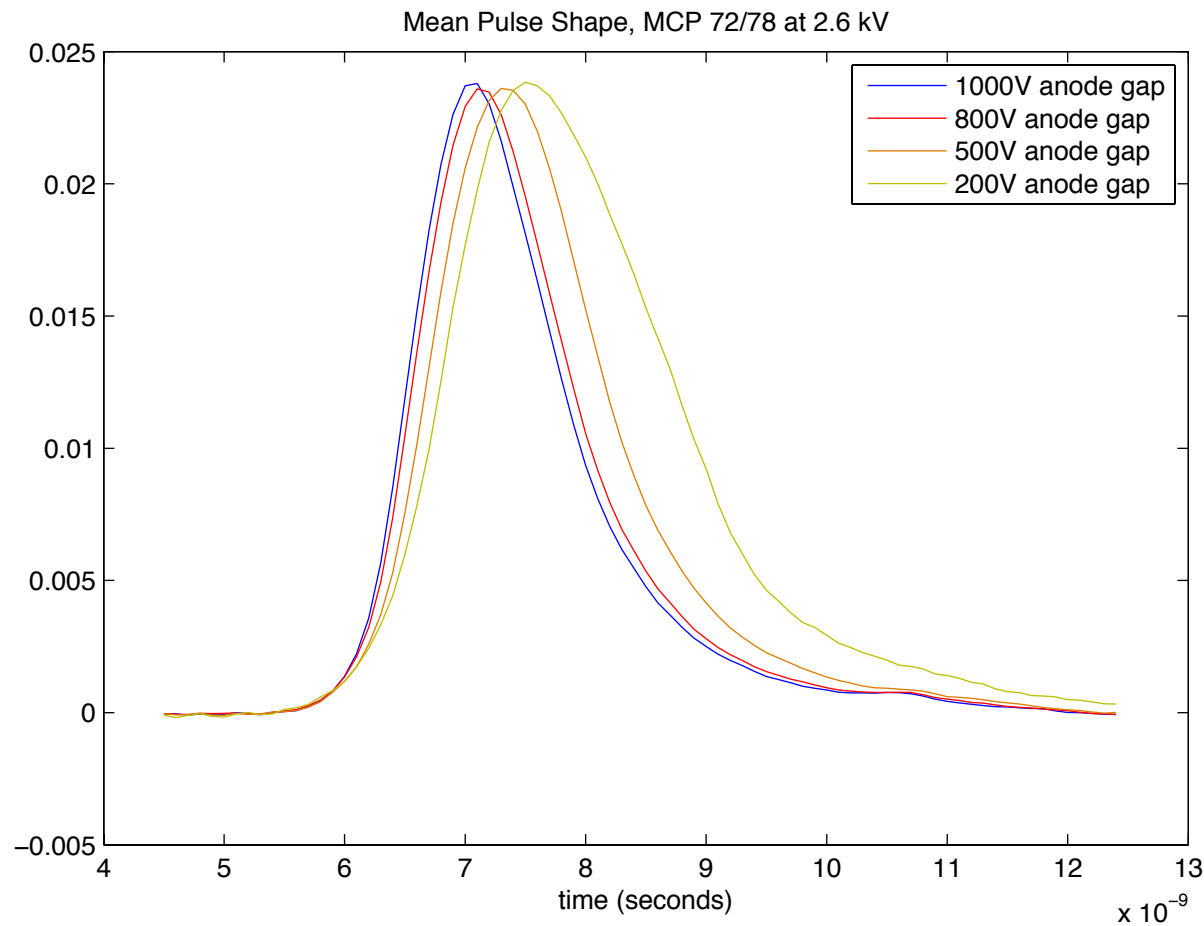
MCP 64/65



difficulties weaving
together different
data to form a
cohesive pulse
height distribution

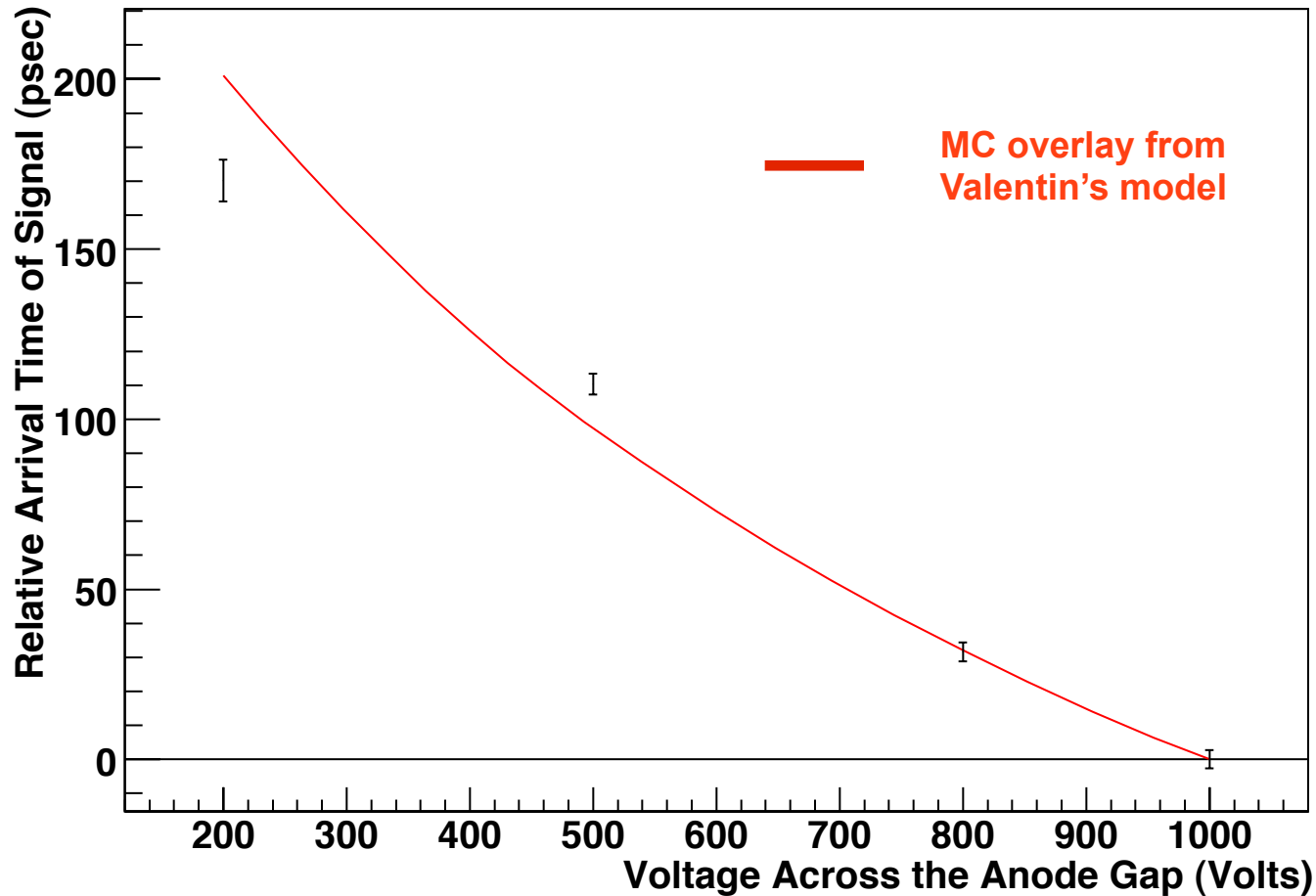


MCP 72/78



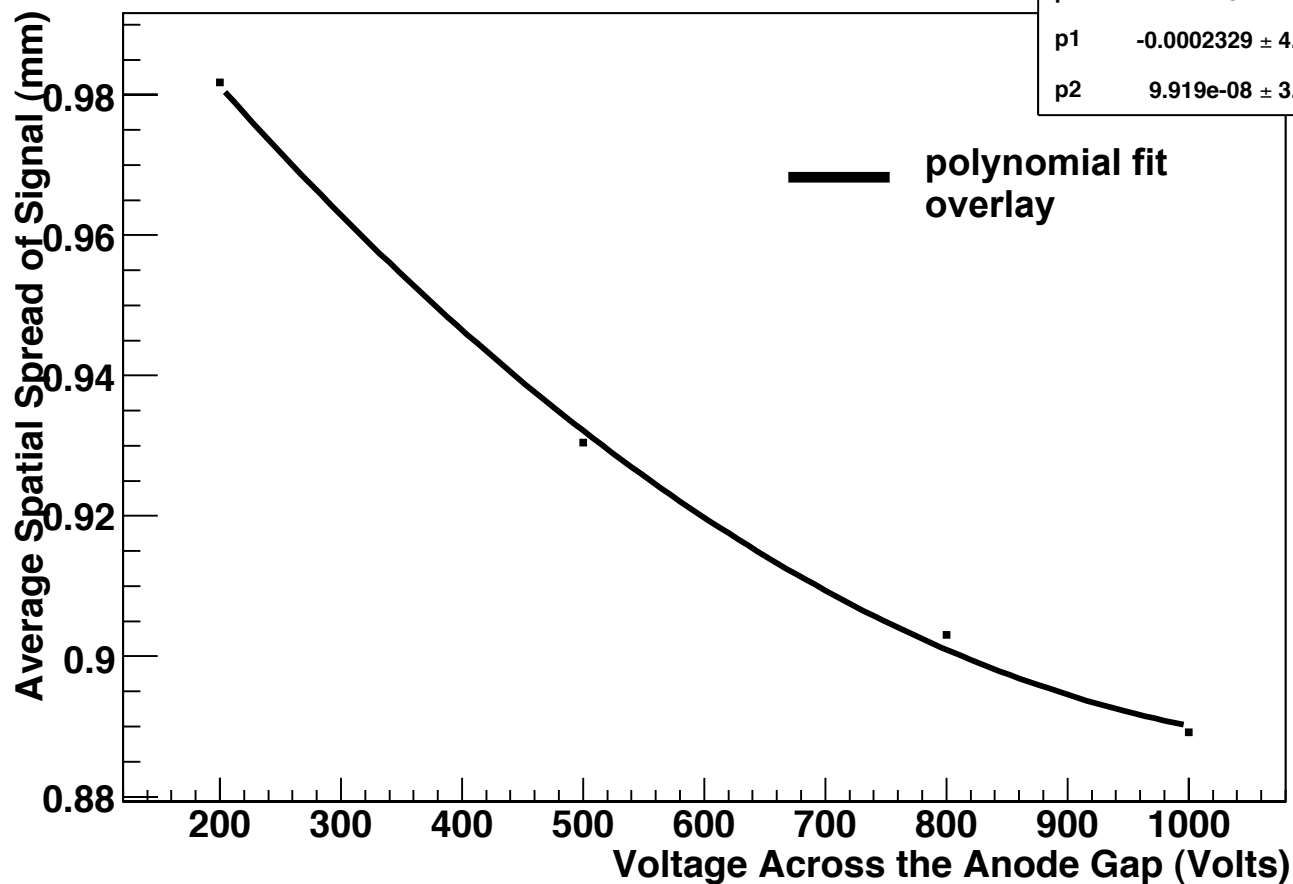
MCP 72/78

Relative Shift in Mean Arrival Time of Signal Vs Voltage on Anode Gap



MCP 72/78

Spatial Spreading of Signal Vs Voltage on Anode Gap

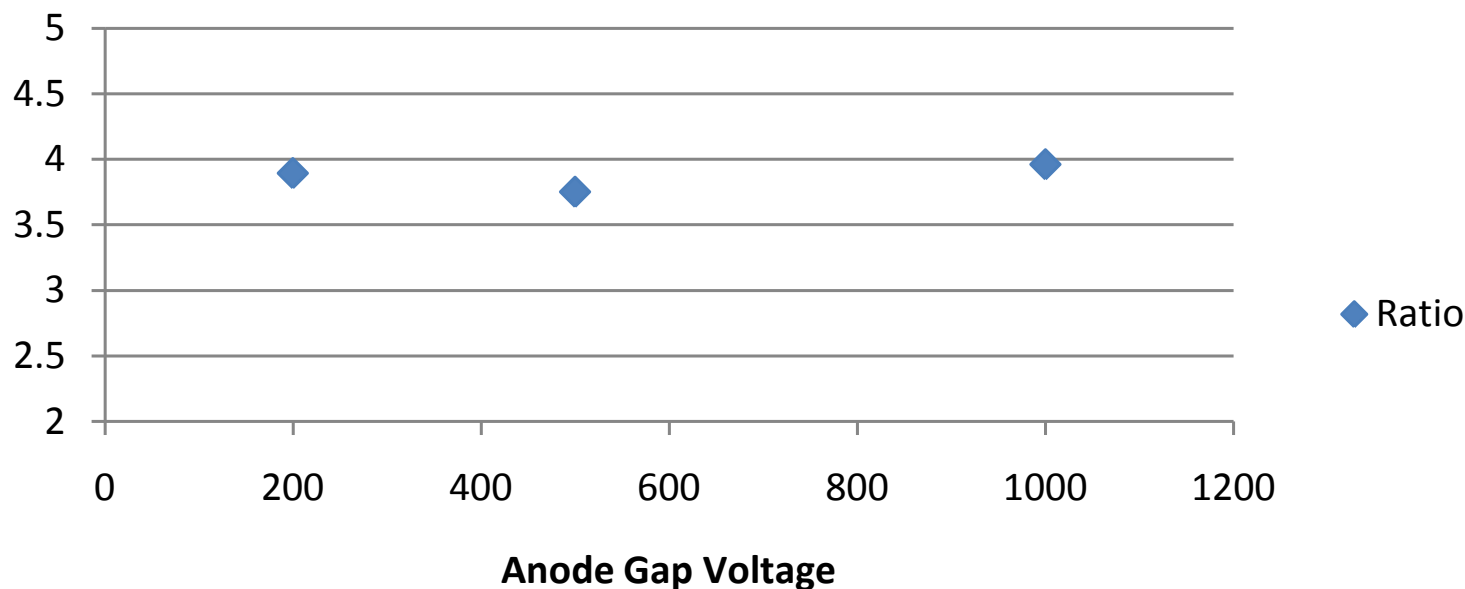


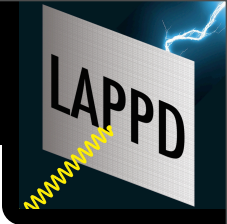
χ^2 / ndf	31.63 / 1
p0	1.024 ± 0.001171
p1	-0.0002329 ± 4.592e-06
p2	9.919e-08 ± 3.765e-09

polynomial fit
overlay

MCP 72/78 Vs MCP 72/88:
20 vs 40 micron pores

Ratio of Average Amplification of MCP 78 over MCP 88





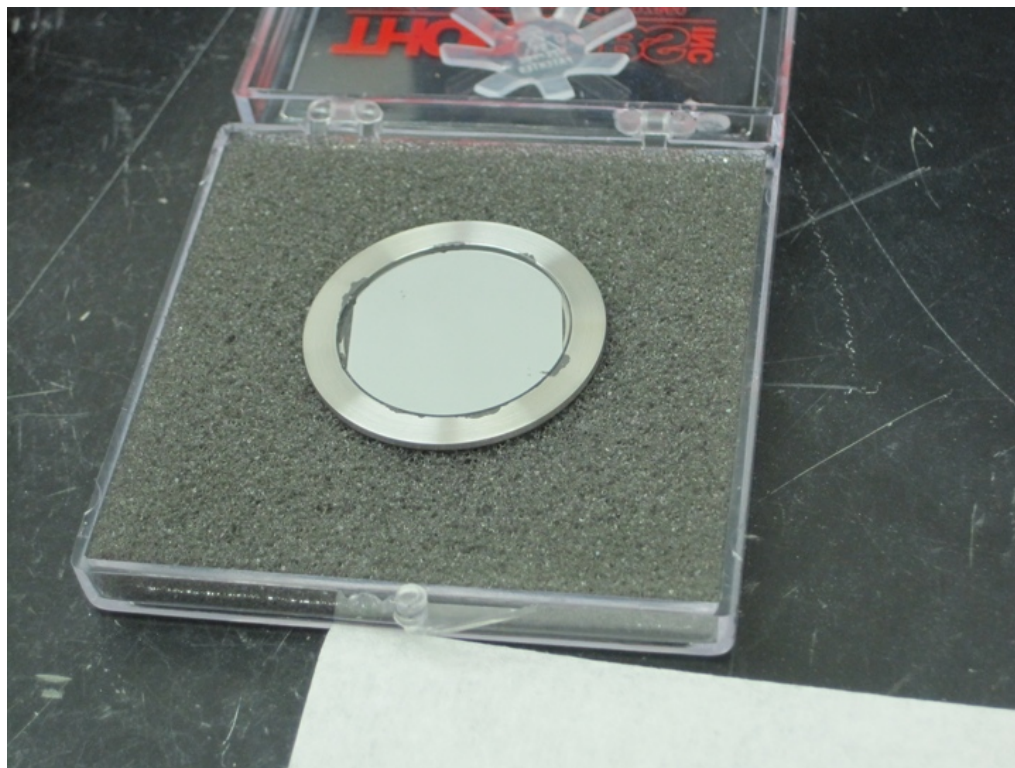
Where We're At With the B Setup

Clean(-er) Sample Preparation



MCP samples are now assembled in a flow bench with dry nitrogen spray gun...

Clean(-er) Sample Preparation

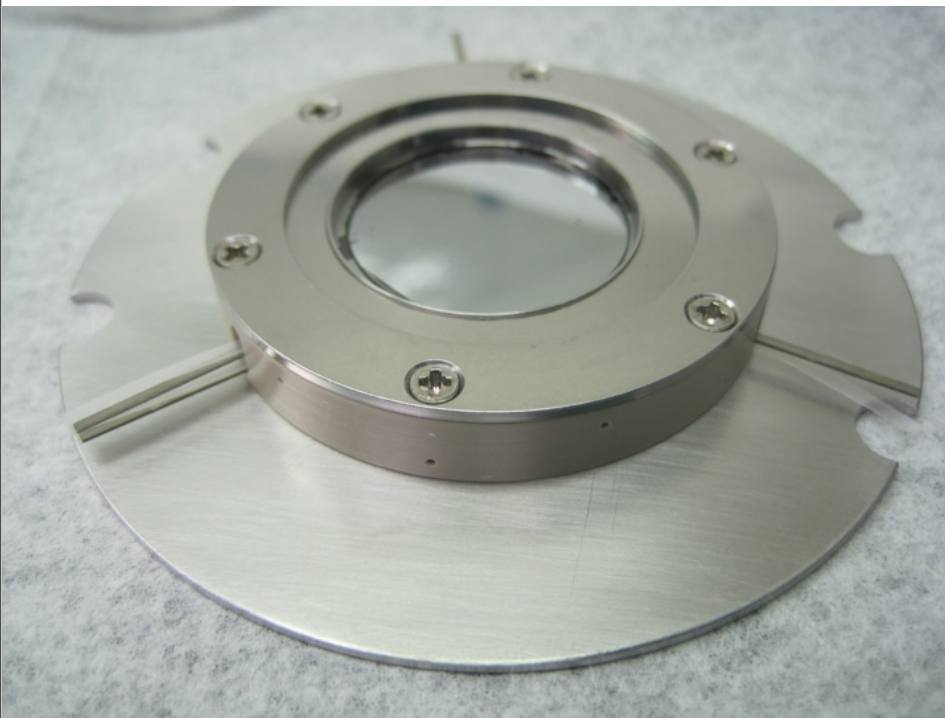


chrome photocathode on sapphire disk

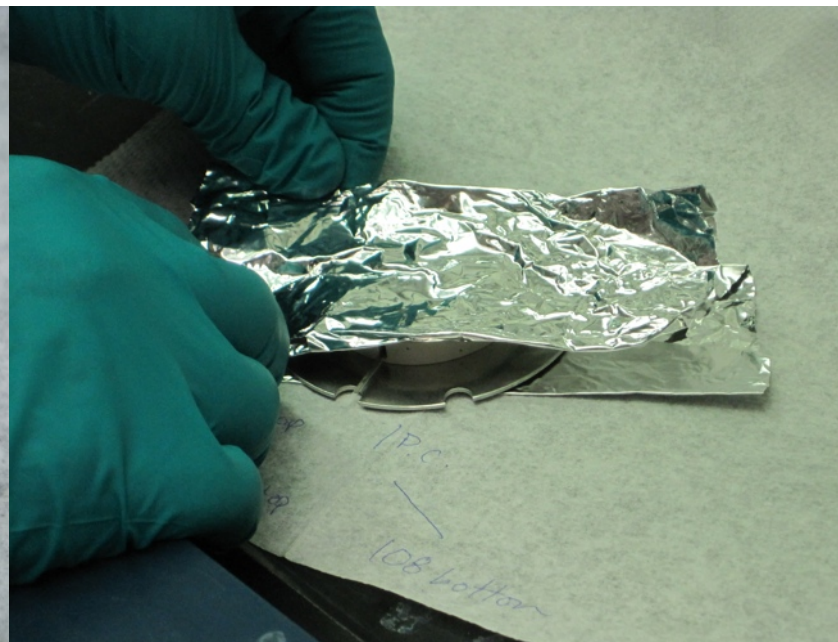


MCP electrodes and pressure pads,
cleaned sonically in an acetone bath

Clean(-er) Sample Preparation

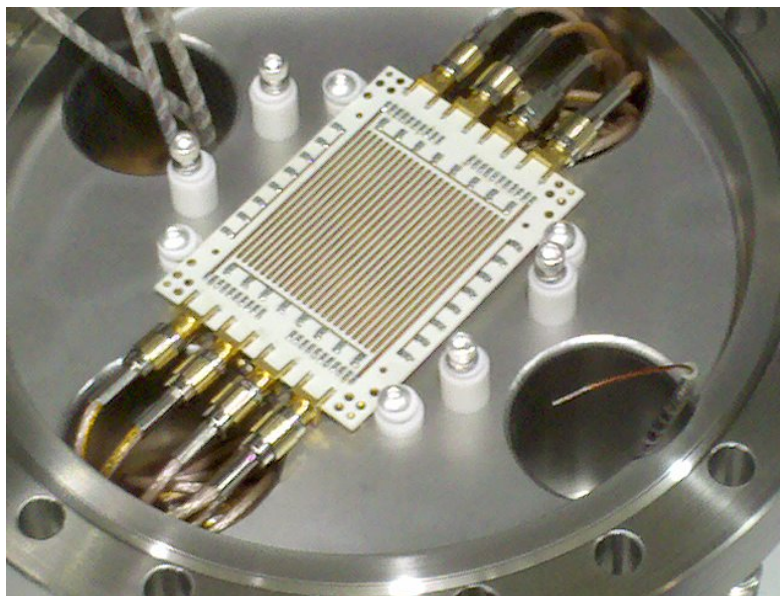


new sample holder with photocathode,
inter-MCP spacing, and 5 HV connections

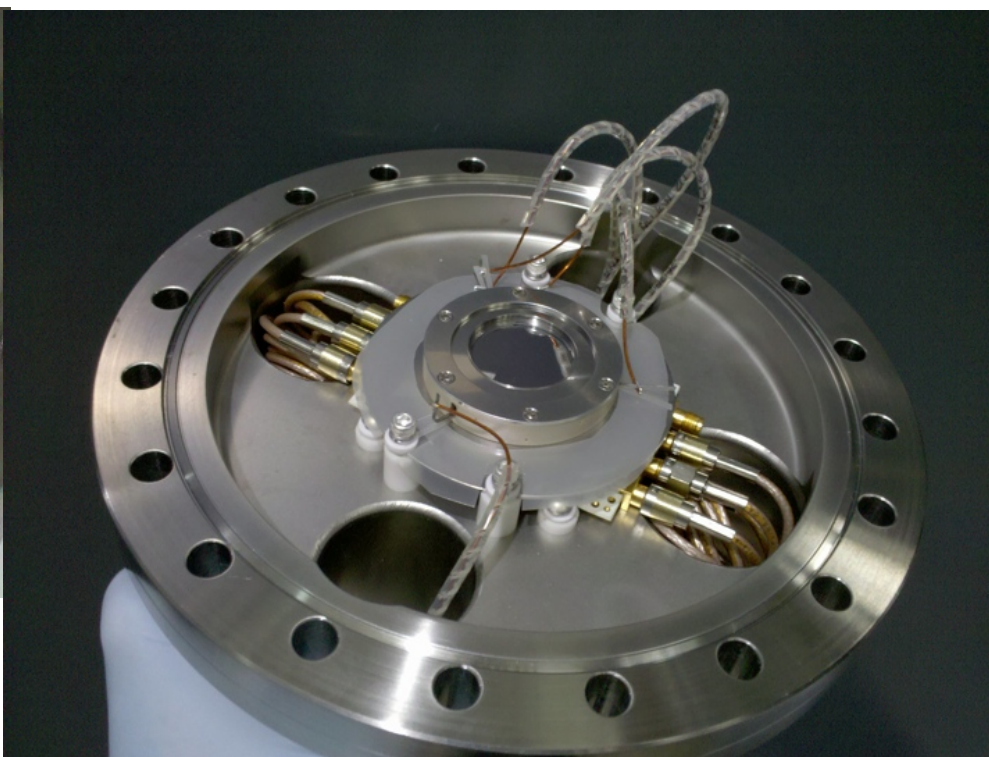


sample holder is covered with UHV-grade
foil to protect from dust during
transportation and mounting into the
chamber

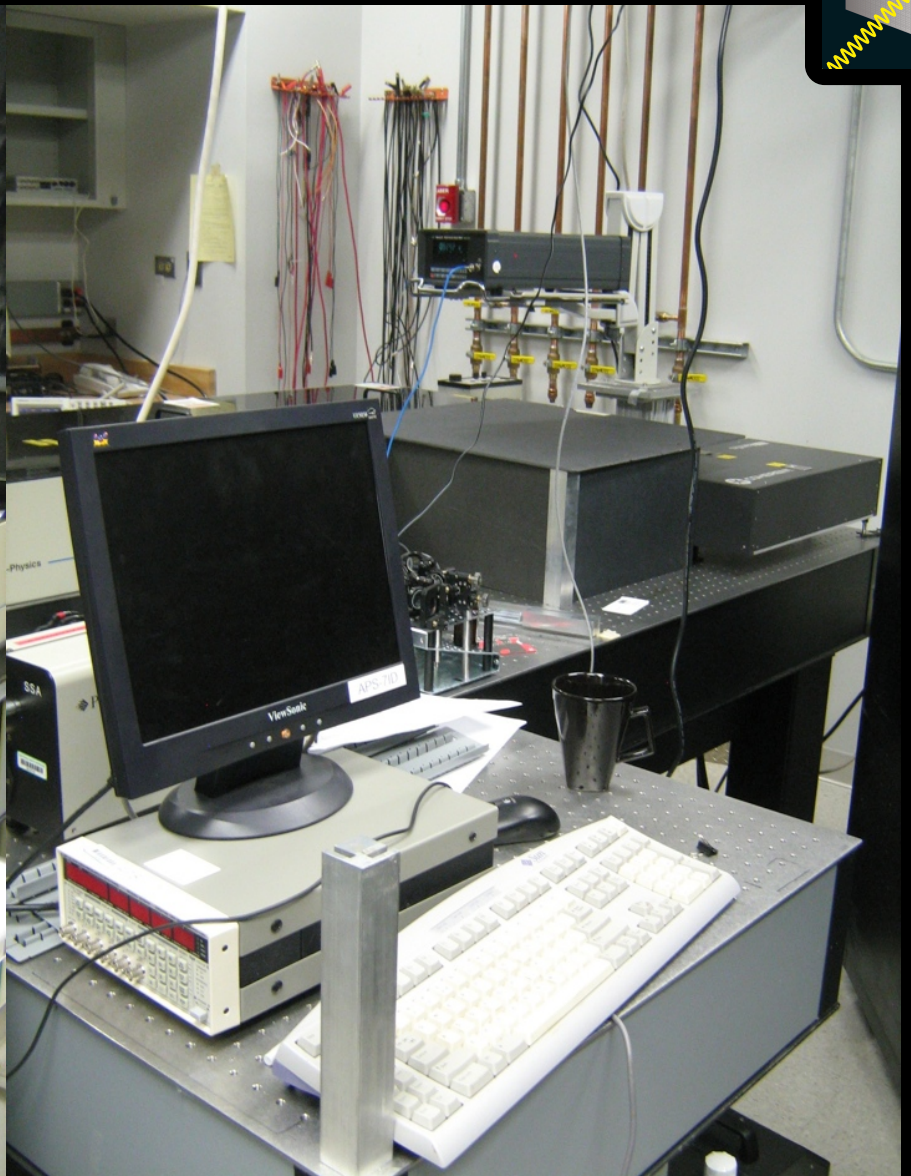
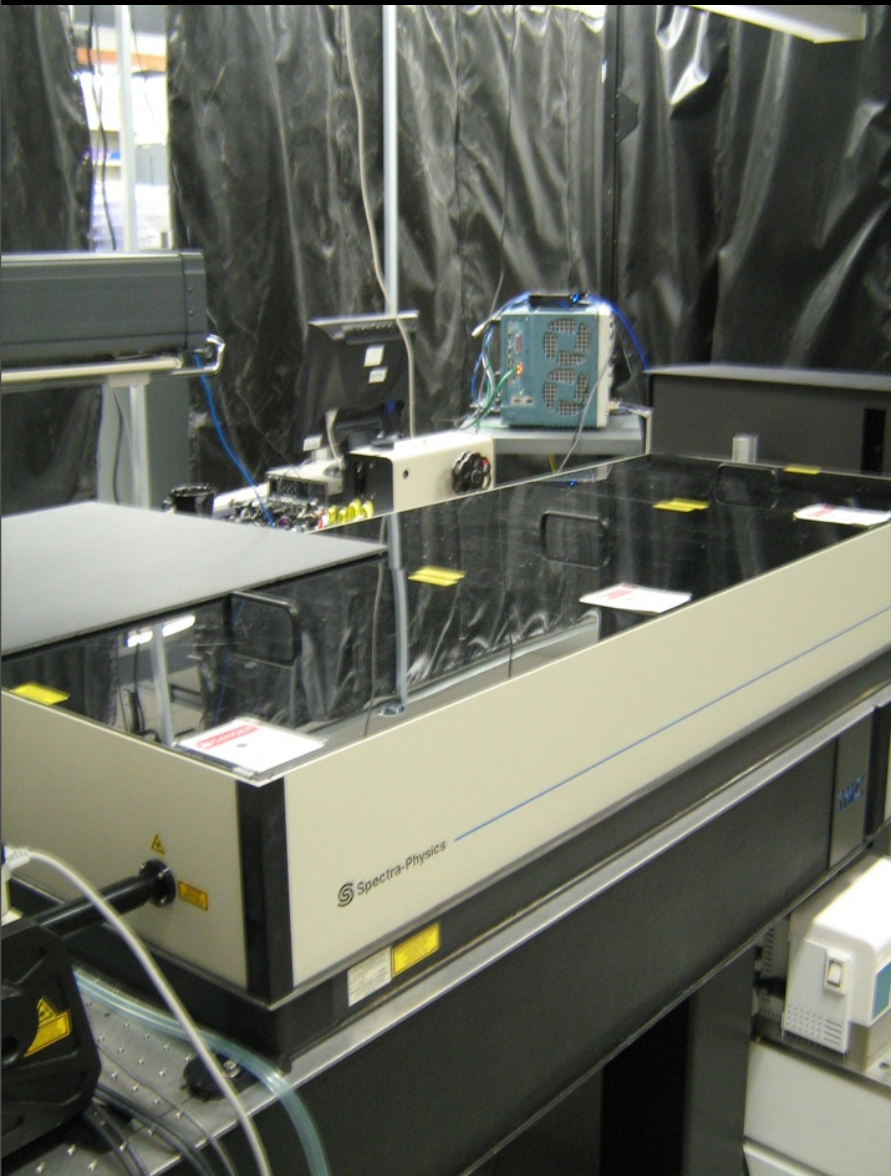
Putting it all together....



new signal board mounted on
the B-flange

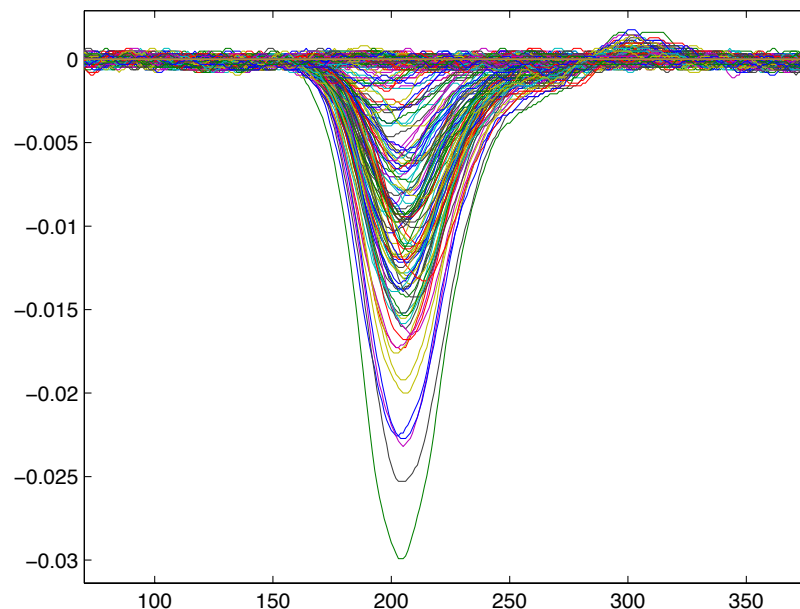
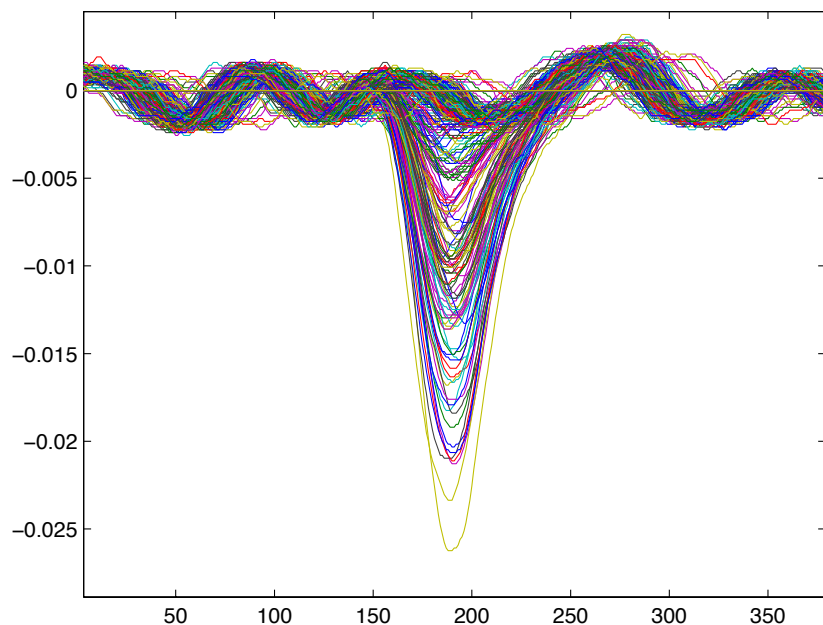


The fully assembled flange...

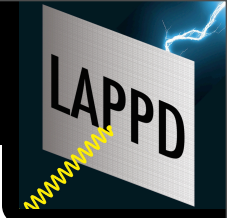


First Signal - New Lab/New Chamber

Noise from the laser (Polkel Cell Driver)!

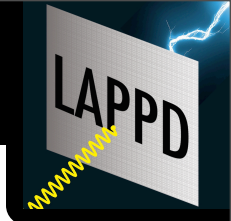


Noise goes away with better cabling...

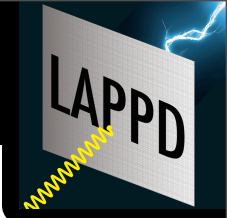


Status, in short...

- Already demonstrated 10^6 gains (project milestone).
- New facilities, dedicated laser, now available
- Automation-ready
- Working on improving handling/cleanliness
- Integrating lessons learned from the B'
- Summarizing B' results
- Ready to start taking measurements



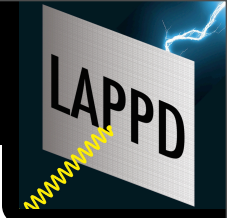
Plans



Testing Challenges

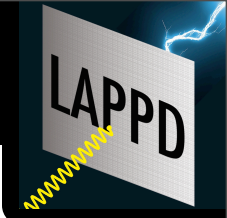
- limited channels - up to 4, maybe 8 (with two scopes)
- limited dynamic range.
- inter-calibration of different scope settings
- electronics issues: DC offsets, pulse shaping
- noise!
- understanding anode effects - lost charge, noise
- controlling photon statistics - QE of photocathode
- precision measurement of optical/electronic delays

This requires a careful, systematic calibration program *in parallel* with testing program. Order matters....



Testing Challenges

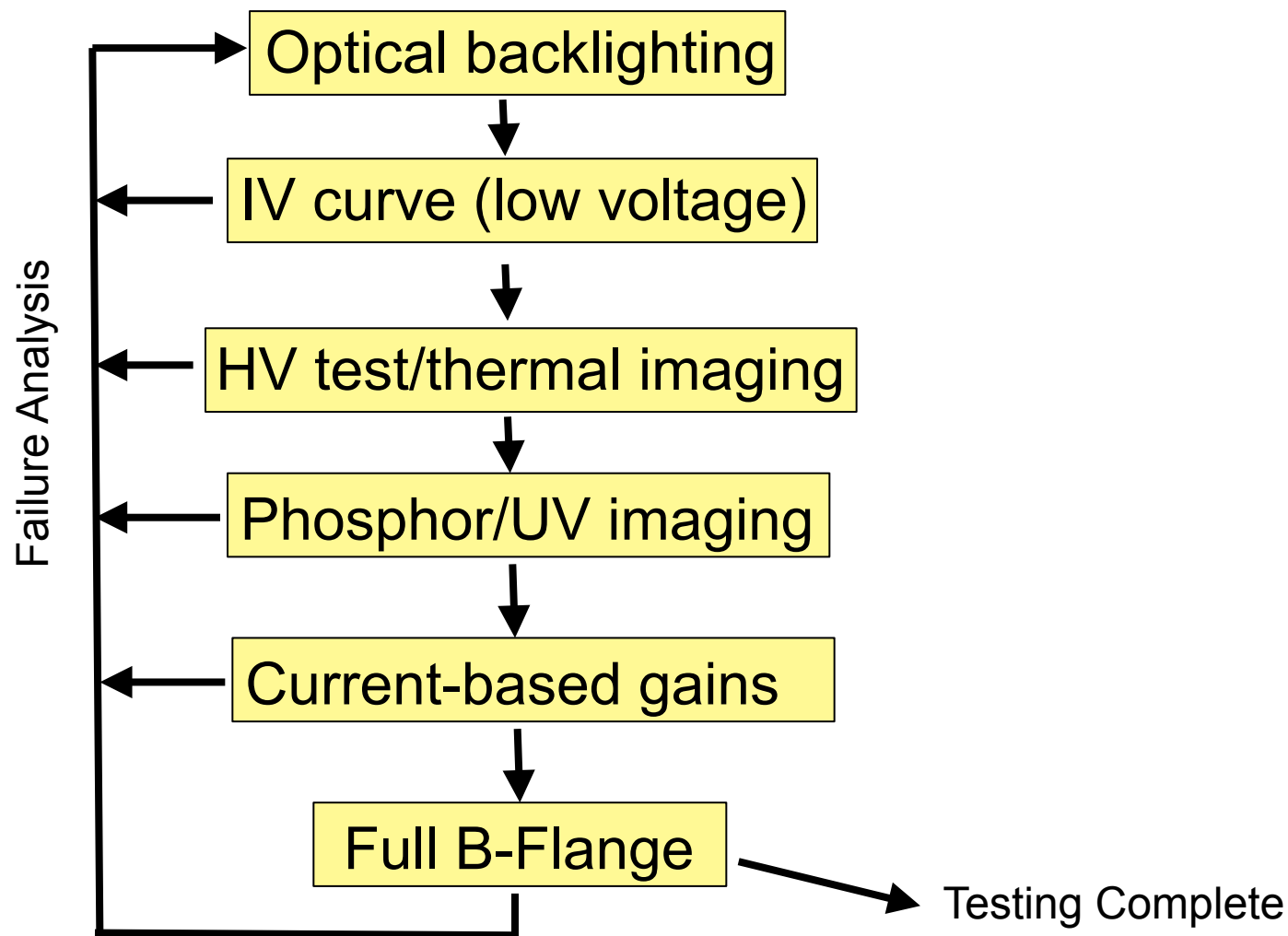
- limited channels - up to 4, maybe 8 (with two scopes)
 - should be enough for small spot-size
- limited dynamic range.
 - measurements at multiple scope scales
- inter-calibration of different scope settings
 - RF grade splitter, identical signal at different scope scales
- electronics issues: DC offsets, pulse shaping
 - baseline measurements, propagating known pulses through the electronics
- noise!
 - appropriate cabling and shielding, long optical delay
- understanding anode effects - lost charge, noise
 - bare anode-cathode measurements for different structures
- controlling photon statistics - QE of photocathode
 - current versus intensity measurements with high light (for “average mode”)
 - photon counting with pair of known commercial plates (for “single PE mode”)
- precision measurement of optical/electronic delays
 - developing a quick, regular procedure. 3/4's of the way there...

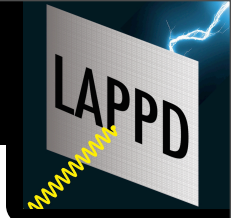


Testing Categories

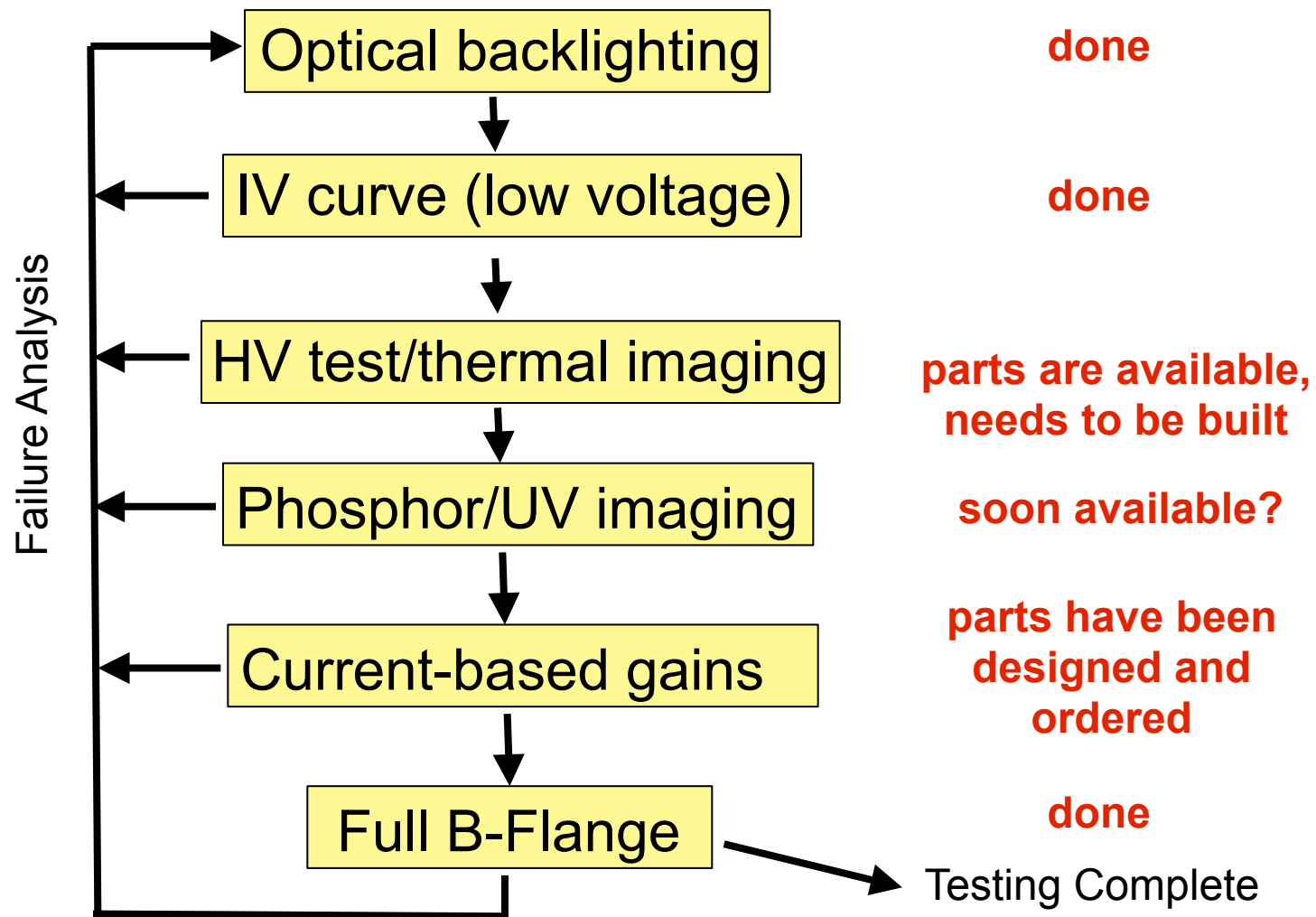
1. anode testing
 - single plate, PC board, glass, inside-out
2. single-plate testing in “average” mode
 - pulsed, many PEs per pulse, known input charge
3. “oreo cookie” testing
4. testing in single PE mode
 - (a) single plate
 - gain and timing, pulse height distributions, different chemistries and voltages
 - (b) two-plate
 - operational voltages, gain, timing, saturation, different chemistries/ combinations
5. 8” testing
6. sample consistency/long-term stability

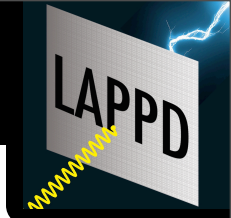
Coordination with ALD Group





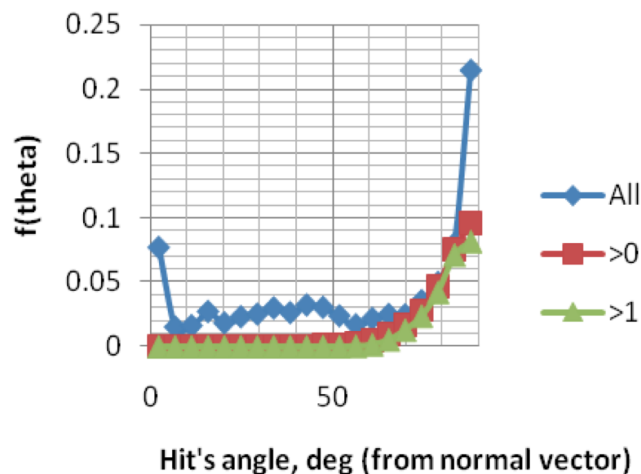
Coordination with ALD Group



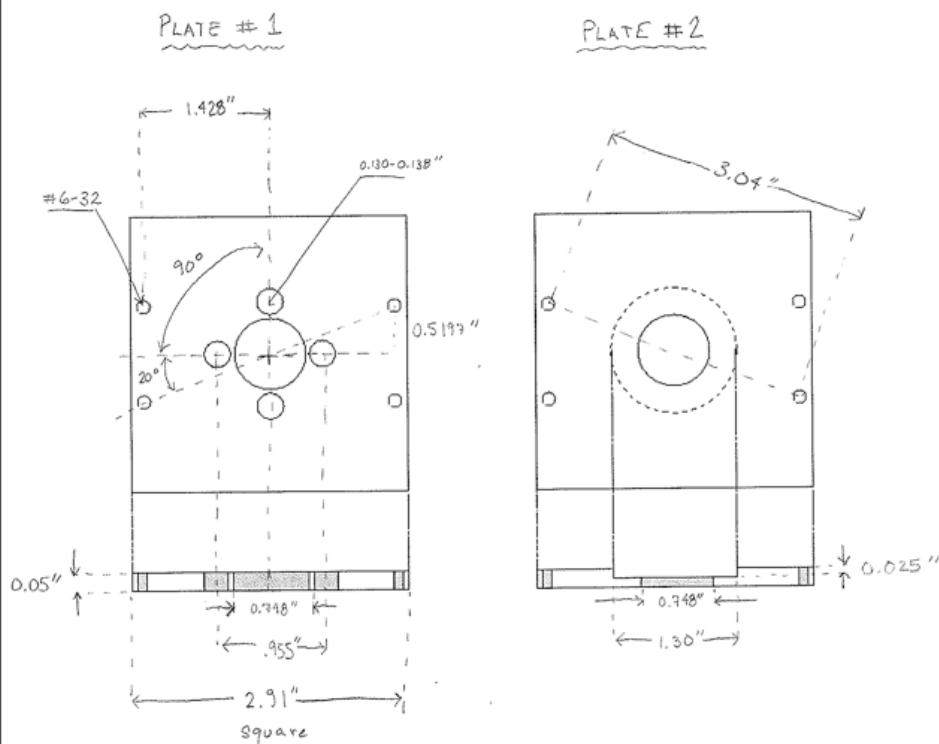


Coordination with Simulations

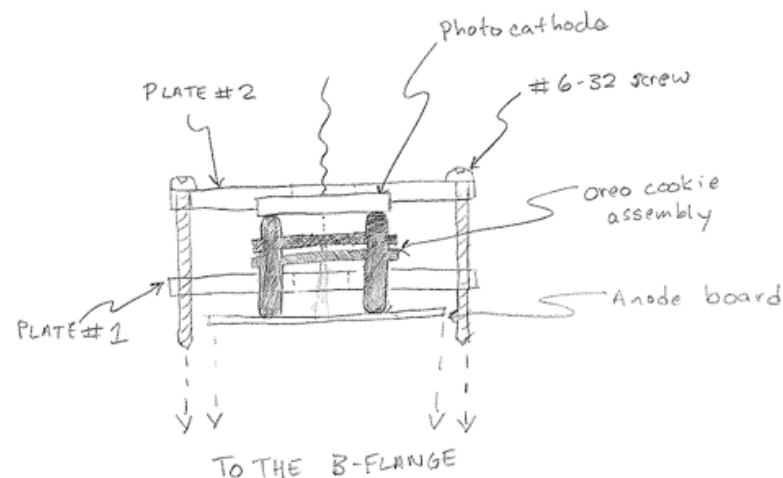
- Meeting/brainstorming session with Valentin in August
- Finishing up a note on the meeting
- Achievements
 - modularization of the code
 - now operational in a linux environment
 - goal to mass produce single-plate MC, using a simple batch system
- Conceptual questions
 - origin of statistical variability
 - back-scattering/elastic scattering
 - imperfect/varying materials
 - operational parameters
- Benchmarks
 - single plate data-MC comparisons
 - MC-MC comparisons with Arradiance MC



"Oreo" Testing



"HOW TO MAKE AN OREO COOKIE"
SANDWICH



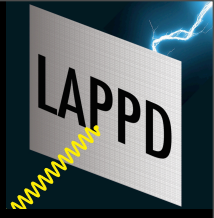
- mechanical assembly is being made now
- testable on B-flange
- should be ready, before the month's end

8" Testing

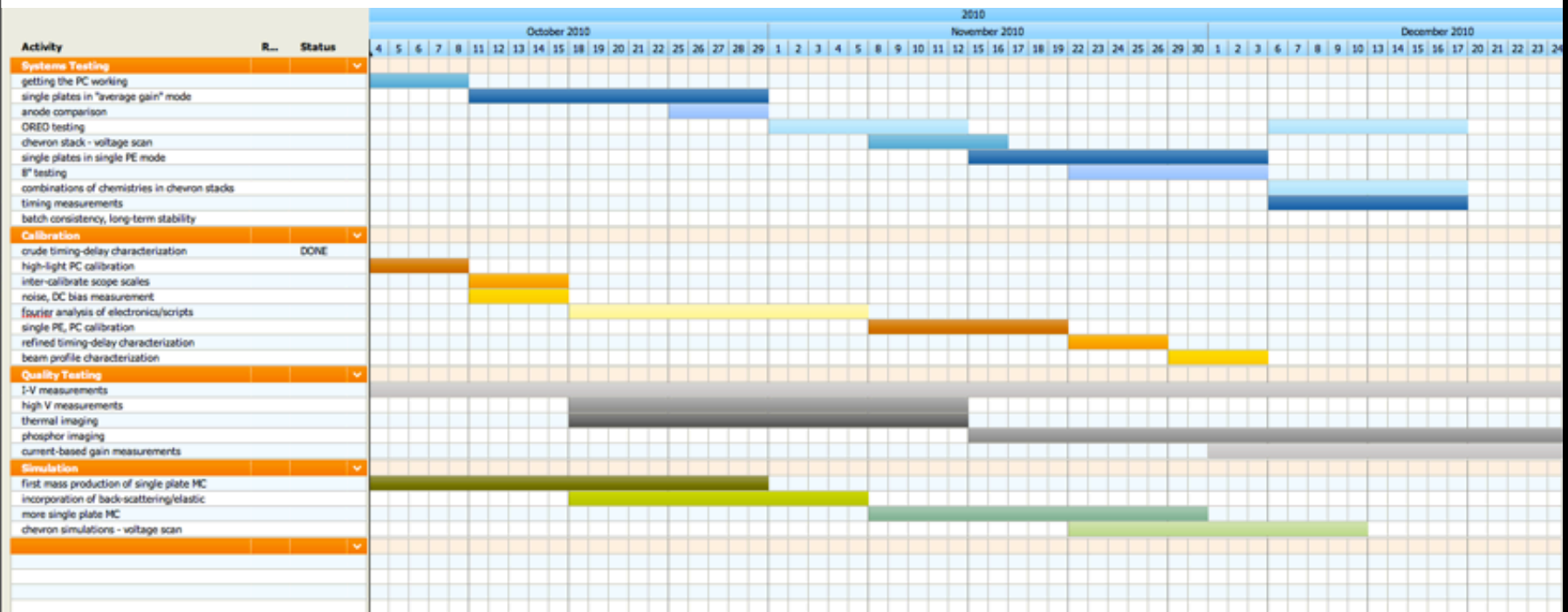
All the vacuum components of the 8" chamber are purchased and ready...

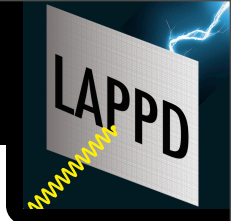
Working to design a simple, glass or alumina assembly to couple 8" plates to a stripline anode...Hope to be ready to test 8" plates by late November.





Putting it all together...





Making Plans

- Things are looking good
- Worried a bit about man-power
 - lots of measurements
 - acquisition and analysis are time consuming (shifts?)
- Also worried about swapping between chambers (8" testing), oreo cookies...
- Hoping to nail down a realistic schedule that balances all of our priorities (8"/oreo/single-plate/double plate/chemistries/voltages)
- Hoping to start measuring single-plates in a week or so.